

Device Modeling Report

COMPONENTS:

DIODE/ GENERAL PURPOSE RECTIFIER/ STANDARD

PART NUMBER: S5566G

MANUFACTURER: TOSHIBA

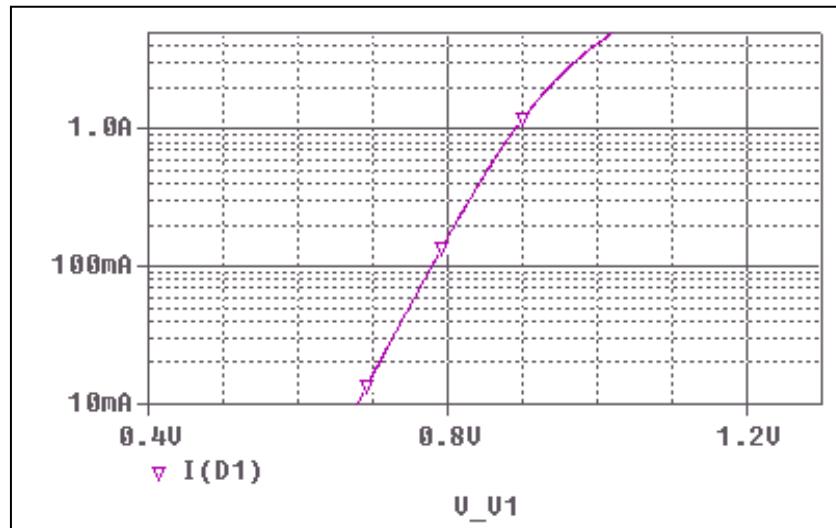


Bee Technologies Inc.

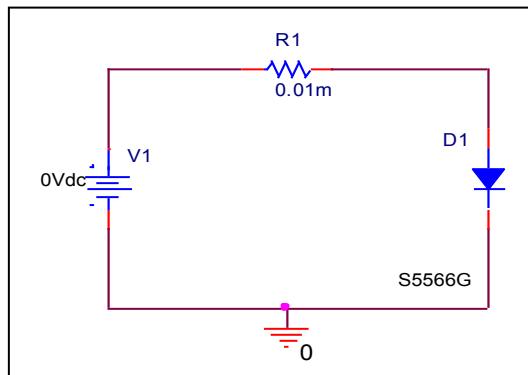
PSpice model parameter	Model description
IS	Saturation Current
N	Emission Coefficient
RS	Series Resistance
IKF	High-injection Knee Current
CJO	Zero-bias Junction Capacitance
M	Junction Grading Coefficient
VJ	Junction Potential
ISR	Recombination Current Saturation Value
BV	Reverse Breakdown Voltage(a positive value)
IBV	Reverse Breakdown Current(a positive value)
TT	Transit Time
EG	Energy-band Gap

Forward Current Characteristic

Circuit Simulation Result

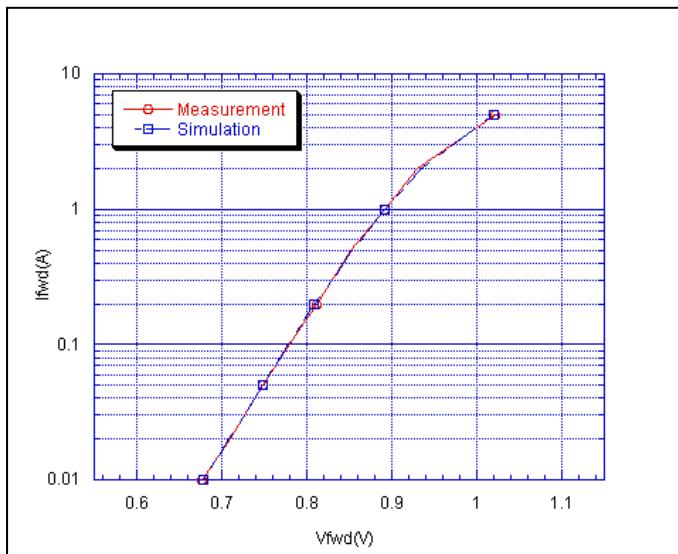


Evaluation Circuit



Comparison Graph

Circuit Simulation Result

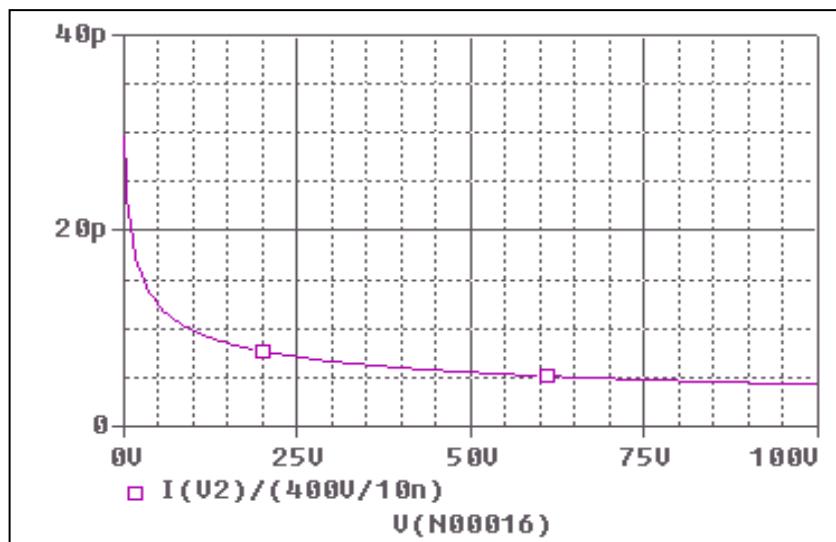


Simulation Result

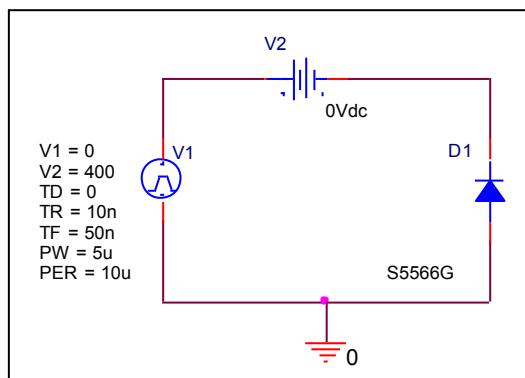
$I_{fwd}(A)$	$V_{fwd}(V)$ Measurement	$V_{fwd}(V)$ Simulation	%Error
0.01	0.676	0.679	-0.444
0.02	0.710	0.708	0.282
0.05	0.748	0.745	0.401
0.1	0.780	0.778	0.256
0.2	0.812	0.809	0.369
0.5	0.852	0.853	-0.117
1	0.892	0.891	0.112
2	0.930	0.935	-0.538
5	1.022	1.020	0.196

Junction Capacitance Characteristic

Circuit Simulation Result

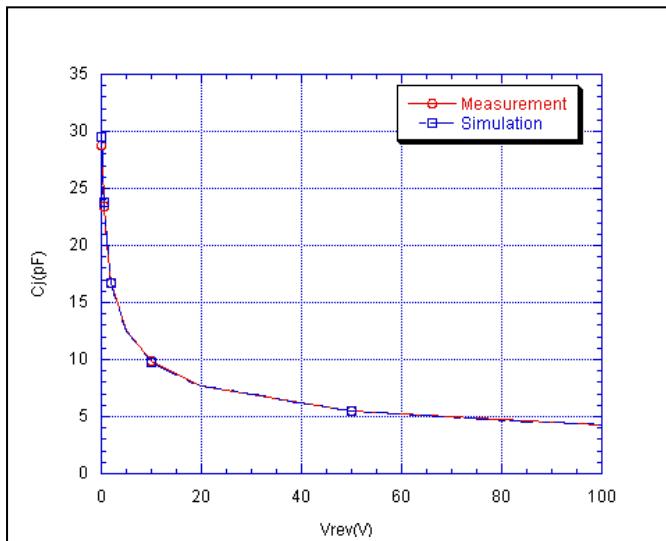


Evaluation Circuit



Comparison Graph

Circuit Simulation Result

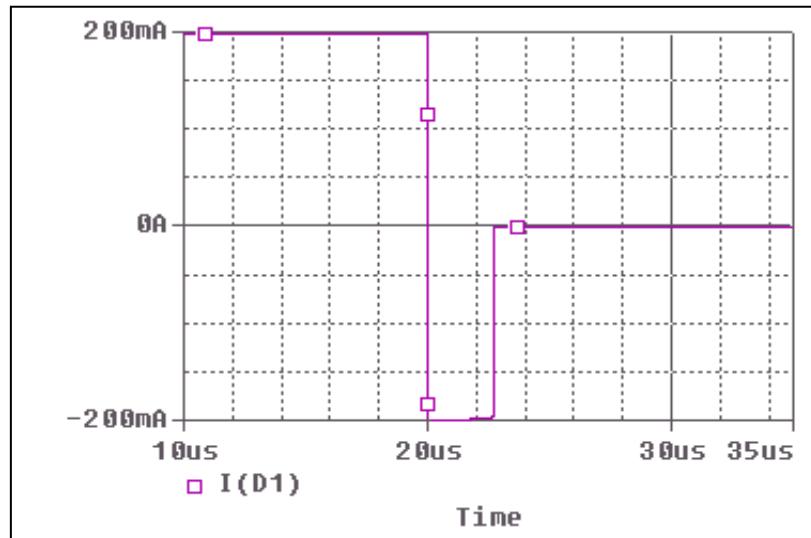


Simulation Result

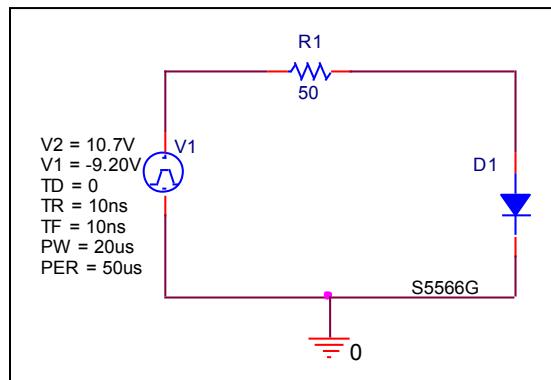
V_{rev} (V)	C_j (pF) Measurement	C_j (pF) Simulation	%Error
0	31.000	31.000	0.000
0.1	28.800	29.543	-2.580
0.2	27.087	27.654	-2.093
0.5	23.444	23.771	-1.395
1	20.166	20.571	-2.008
2	16.680	16.737	-0.342
5	12.569	12.449	0.955
10	9.935	9.815	1.209
20	7.741	7.685	0.722
50	5.445	5.525	-1.473
100	4.111	4.202	-2.221

Reverse Recovery Characteristic

Circuit Simulation Result



Evaluation Circuit

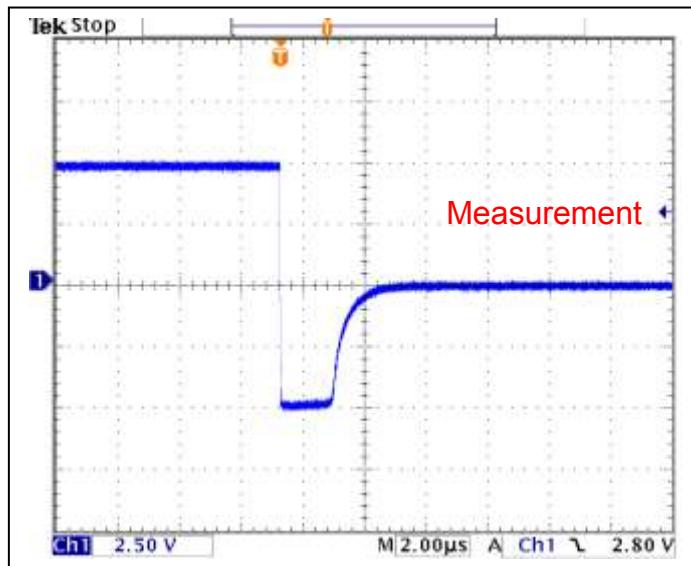


Compare Measurement vs. Simulation

	Measurement		Simulation		%Error
trr	2.72	us	2.70	us	0.735

Reverse Recovery Characteristic

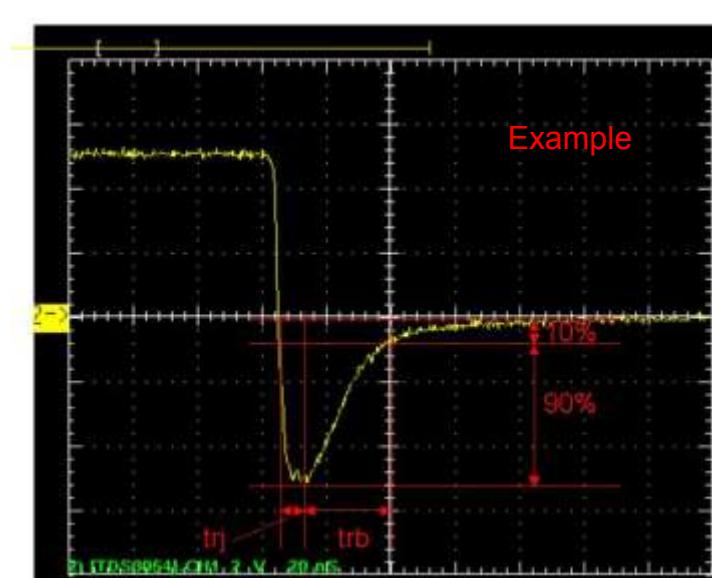
Reference



$Trj = 1.64(\mu s)$

$Trb = 1.08(\mu s)$

Conditions: Ifwd=0.2(A), Irev=0.2(A), RI=50



Relation between trj and trb